


<b>Search Notes</b>  	<b>Application/Control No.</b>  10519740	<b>Applicant(s)/Patent Under Reexamination</b>  JONES ET AL.
	<b>Examiner</b>  JACK YIP	<b>Art Unit</b>  3715

SEARCHED			
Class	Subclass	Date	Examiner
434	323, 29, 62, 63, 64, 65, 69	4/20/2008	Jack Yip
351	203	4/20/2008	Jack Yip
434	323, 29, 62, 63, 64, 65, 69	12/8/2008	Jack Yip
351	203	12/8/2008	Jack Yip

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search	4/20/2008	Jack Yip
eDAN inventor search	4/20/2008	Jack Yip
consult Cameron Saadat for search	4/20/2008	Jack Yip
PLUS search	4/20/2008	Jack Yip
Update East search	12/8/2008	Jack Yip

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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